

New options

96 kHz sampling rate



Audio Analyzer R&S UPL

The solution for the budget-conscious

- ◆ For all interfaces:
analog, digital and combined
- ◆ Real dual-channel measurements
- ◆ Maximum dynamic range
- ◆ FFT analysis
- ◆ Jitter analysis

- ◆ Interface tester
- ◆ Freely programmable filters
- ◆ Versatile functions
- ◆ Compact unit with integrated PC
- ◆ Automatic test sequences
- ◆ Extensive online help

New options:

- ◆ 3G Mobile Phone Test (R&S UPL-B9)
- ◆ LAN Interface (R&S UPL-B11)
- ◆ Coded Audio Signal Generation (R&S UPL-B23)



ROHDE & SCHWARZ

Audio analysis today and tomorrow

Analog and digital

Audio signal processing without digital technology is no longer conceivable. Yet, analog technology is still present and constantly being improved. State-of-the-art measuring instruments must therefore be able to handle both analog and digital signal processing.

The Audio Analyzer R&S UPL performs virtually every type of analog measurement: frequency response measurements; externally controlled sweeps with reference traces; determination of 3rd order difference frequency distortion; or spectral display of demodulated wow and flutter signals. In contrast to many other audio analyzers, the R&S UPL can perform real dual-channel measurements in the audio-frequency range, i.e. there is no need for

switchover between two inputs and this type of measurement is not limited to a few special cases.

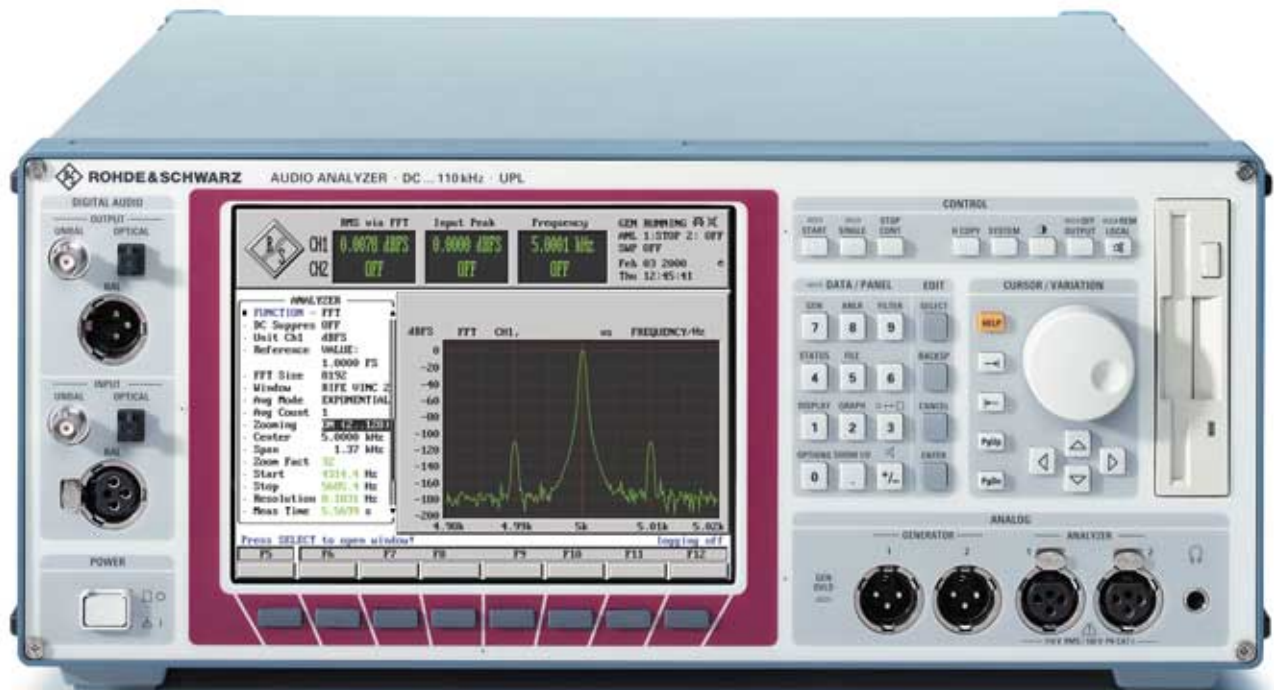
The generator is equally versatile: it supplies any conceivable signal whether sine wave, noise signals, or multi-sine wave signals comprising up to 7400 frequencies.

In addition, the R&S UPL features excellent technical data: analog sine wave generation with harmonics of typ. -120 dB; spectrum displays with a noise floor below -140 dB for analog and -160 dB for digital interfaces; and FFT with a maximum frequency resolution of 0.05 Hz.

The R&S UPL provides signal monitoring via loudspeaker, jitter measurements on digital audio signals, resynchronization of jittered digital audio signals by means of a jitter-free clock signal, and much more.

Superior analysis concept

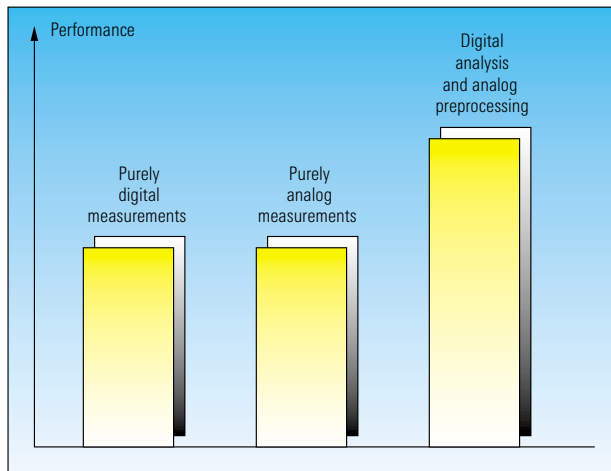
The R&S UPL performs all measurements using digital signal processing. Analog signals to be tested undergo elaborate pre-processing before they are digitized and measured by means of digital routines. For example, in THD measurements, the fundamental is attenuated by means of a notch filter and the residual signal amplified by 30 dB before it is digitized. In this way, the dynamic range can be extended beyond that offered by the internal 20 -bit converter. This provides sufficient margin for measuring converters of the future, which will be more advanced than those with present-day technology (see graph on the right). This concept ensures performance and flexibility by far superior to instruments providing purely analog or digital measurements.



It also offers many other advantages over analog technology alone:

- ◆ The test routines for analog and digital interfaces are identical. This allows, for example, the direct comparison of IMD measurements made ahead of and after a converter.

- ◆ In intermodulation measurements, spurious components are measured selectively for all frequencies in accordance with the mathematical formulae of the applicable test standards. This procedure prevents the inclusion of adjacent components in the measurements, which is usually inevitable with analog test methods.



The intelligent combination of analog and digital measurement techniques paves the way for future applications.

- ◆ All test functions are available on the analog and the digital interfaces. This makes it possible to perform measurements at any point along a common analog and digital transmission path, the only way to ensure efficient and complete testing.
- ◆ The filters are also implemented digitally, yielding a more or less infinite number of them – and this also holds true for measurements on analog interfaces. To loop a new filter into the test path, you merely have to choose the type of filter (e.g. highpass), cut-off frequency and attenuation.
- ◆ Measurement speed is usually higher than with analog techniques since digital test routines can adapt their speed to the input frequency.
- ◆ And last but not least: Operation is the same for the analog and the digital interfaces – a feature that should not be underestimated.

A future-proof investment

No one can accurately predict the effects that future developments in digital technology will have on the audio world and the resulting test requirements. Yet this is not a problem for the Audio Analyzer R&S UPL. Since all test functions are implemented digitally, the R&S UPL can be adapted to changing requirements by simply loading the necessary software – and this also applies to analog interfaces.

One more benefit: Rohde & Schwarz is the only manufacturer to equip its audio analyzers with 32-bit floating-point signal processors throughout, thus offering plenty of capacity beyond the limits of today's common 24-bit technology.

A competent partner

The name Rohde & Schwarz stands for excellent quality – thousands of audio analyzers are already in the hands of satisfied customers and have been operating successfully for many years. Following in the footsteps of the exclusively analog R&S UPA and R&S UPD, which still hold the top position in today's audio measurement technology, the Audio Analyzer R&S UPL was developed to complement the product line.

As a competent partner we will be happy to advise you on the optimum use of our instruments. Our representatives are available all over the world, and our customer support center and application engineers in Munich can help you find the right solution to your measurement tasks. In addition, a wealth of suggestions and solutions can be found in our application notes and software.

As part of our emphasis on quality, Rohde & Schwarz instruments are certified in compliance with ISO 9001 and ISO 14001.

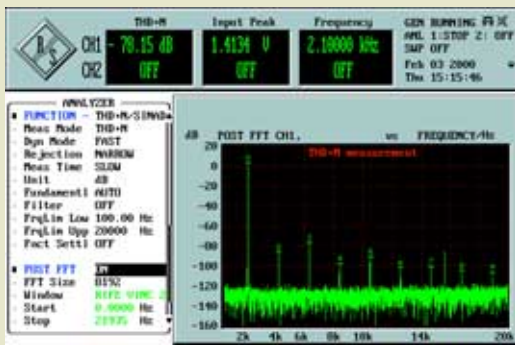


Fig. 1: Automatic marking of harmonics in THD+N measurements makes nonharmonics visible at a glance.



Fig. 2: THD measurements can include single harmonics, all harmonics or any combination of harmonics.

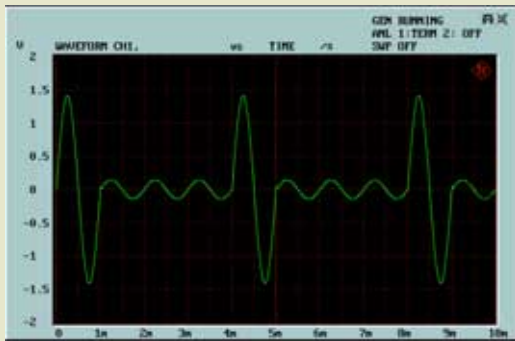


Fig. 3: The waveform function displays the test signal in the time domain. The example shows a sine wave burst.

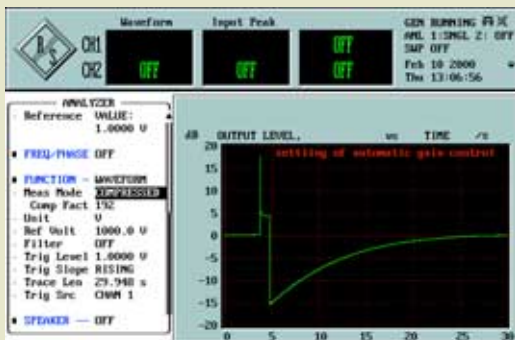


Fig. 4: The transient characteristics of an AGC play an important role in testing hearing aids or automatic volume control on tape recorders.

It does it all

Test signals – made to order

The generators of the R&S UPL supply an extremely wide variety of analog and – when the options R&S UPL-B2 or R&S UPL-B29 are used – digital test signals:

- ◆ **Sinewaves**

For level and harmonic distortion measurements. The signal can be applied to an equalizer with selectable nominal frequency response, e.g. for compensating the frequency response of the test assembly.

- ◆ **Two-tone signal**

For modulation distortion analysis. Various amplitude ratios can be selected and the frequencies are continuously adjustable.

- ◆ **Difference tone signal**

For intermodulation measurements with continuous setting of both frequencies.

- ◆ **Multitone signal**

Can comprise up to 17 sinewaves of any frequency and with the same or different amplitude; setting the phase is also possible with the R&S UPL-B6.

- ◆ **Sine burst signal**

With adjustable interval and on-time as well as programmable low level, e.g. for testing AGCs.

- ◆ **Sine2 burst**

Also with adjustable interval and on-time, e.g. for testing rms rectifier circuits.

- ◆ **Special multitone signal**

Can comprise up to 7400 frequencies with selectable amplitude distribution. The frequency spacing can be linked to the resolution used for the fast Fourier transform, thus enabling rapid and precise single-shot measurements of the frequency response of a DUT.



- ◆ **Noise**

With a variety of probability distributions, e.g. for acoustic measurements; setting of crest factor with the R&S UPL-B6.

- ◆ **Arbitrary waveforms**

For generating any voltage curve of up to 16k points. Test signals can be output in different file formats, e.g. voice and music signals stored as WAV files.

- ◆ **Two-channel sinewave signals**

For the two digital output channels when the UPL-B6 is used.

- ◆ **AM and FM**

For sinewave signals.

- ◆ **DC**

Also with sweep function.

Signals can be generated with an offset. Moreover, digital audio signals can be dithered with adjustable level and selectable amplitude distribution.



Versatile test functions

The R&S UPL offers a wealth of measurement functions both for analog and – when the option R&S UPL-B2/-B29 is used – for digital interfaces.

◆ Level or S/N

This function includes rms, peak or quasi-peak weighting and ensures high measurement speeds due to automatic adaptation of integration time to the input signal.

◆ Selective level

The center frequency of the bandpass filter can be swept or coupled to the generator frequency, to the frequencies of a multitone signal (e.g. for fast frequency response measurements) or to the input signal.

◆ SINAD or THD+N

The sum of all harmonics and noise is measured (Fig. 1).

◆ Total harmonic distortion (THD)

Individual harmonics, all harmonics or any combination of harmonics can be measured (Fig. 2).

◆ Modulation distortion

This measurement complies with DIN-IEC 268-3. 2nd and 3rd order intermodulation is measured.

◆ Difference Frequency Distortion

This intermodulation measurement uses the difference tone method. 2nd and 3rd order intermodulation is measured.

◆ Wow and flutter

This measurement uses the DIN IEC, NAB, JIS or 2-sigma method in accordance with DIN IEC and also displays the demodulated-signal spectrum.

◆ DC voltage

◆ Frequency, phase and group delay

◆ Polarity

Signal paths are checked for reversed polarity.

◆ Crosstalk

◆ Waveform function

This function is used to represent the test signal in the time domain (Fig. 3). Waveforms can be smoothed by interpolation. Slow sequences can be displayed compressed, e.g. for analyzing the transient response of compander or AGC circuits (Fig. 4).

◆ Extended Analysis Functions

R&S UPL-B6

The **coherence and transfer functions** determine the transfer characteristics of complex test signals; **third octave analysis** is used mainly for acoustic measurements; **rub & buzz** is measured in loudspeaker production.



Tests on hi-fi components call for increasingly complex measurement techniques. Results obtained in the test lab must be verified in production, which usually requires economical solutions for handling large batches rather than the use of all available functions. The R&S UPL is an ideal choice for this task. It optimally complements its "bigger brother", the Audio Analyzer R&S UPD, which is mainly employed in development. The two units share the exact same IEC/IEEE bus commands, which means they have the same operating concept and can be used together.

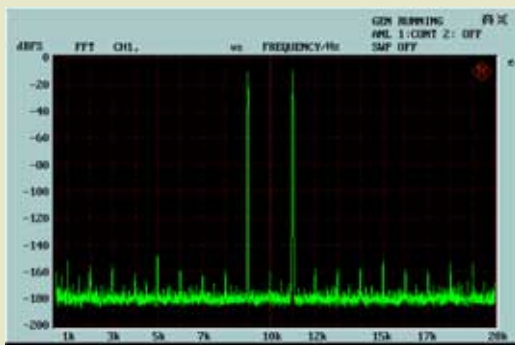


Fig. 5: FFT spectrum of two-tone signal shown on full screen.

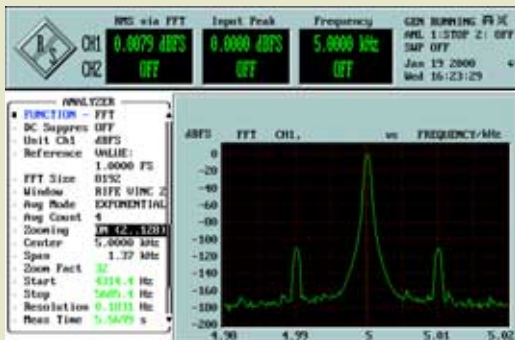


Fig. 6: With the zoom FFT function, sidebands spaced only a few hertz from the signal can be displayed.

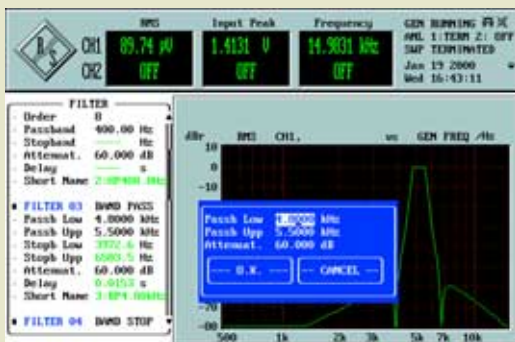


Fig. 7: Filters can be defined by entering just a few parameters.

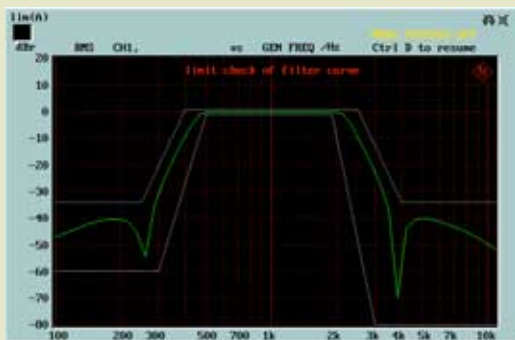


Fig. 8: Tolerance curves enable fast go/no-go tests.

Spectrum analysis

With its FFT analyzer, the R&S UPL is also capable of spectrum analysis. The number of samples for fast Fourier transform can be selected between 256 and 16k in binary steps (Fig. 5). A special feature is zoom FFT. The signal to be measured is digitally pre-processed to increase the frequency resolution by a factor of 2 to 128 over a selectable range. In this way, a maximum resolution of 0.05 Hz is attained. This is not merely a scale expansion, the measurement is actually performed at a higher resolution (Fig. 6).

Programmable filters

The filters of the R&S UPL are software-implemented, allowing the user to define any number of filters. The most common weighting filters are provided as standard. Additional filters can be programmed in a few seconds by entering the type (lowpass, highpass, bandpass, bandstop, notch, third octave or octave), frequency and attenuation (Fig. 7). The instrument's open architecture reveals its strength particularly where special requirements have to be met: special filters can be implemented by using commercial filter design programs. The data is transferred to the R&S UPL and the required filter is looped into the signal path.

A variety of sweep functions

For continuous variation of the test signals, the R&S UPL offers amplitude and frequency sweeps; in the case of bursts, it is also possible to perform sweeps of intervals and on-time. Sweeps are defined either by means of a table or via parameters such as start value, number of steps, linear/ log stepping or time interval. It is also possible to sweep two variables simultaneously.

If external signals are applied during measurement, they can be used for analyzer sweeps (external sweeps). Many different start conditions can be set, allowing measurements to be triggered by a variety of events. Even if the DUT has an unknown or unstable transient response, the settling function will yield stable results.

Multichannel measurements with Audio Switcher R&S UPZ

The Audio Switcher R&S UPZ is used either to measure surround sound decoders or in production if several DUTs/channels have to be cabled. It is directly connected to the Audio Analyzer R&S UPL and panel-controlled via an RS-232-C interface. The 8-channel R&S UPZ is available as an input and output model and can be cascaded to up to 128 channels. *)



The Audio Switcher R&S UPZ can be controlled directly from the R&S UPL.

*) For more information, refer to data sheet PD 0757.6985, Multichannel audio measurements on surround sound decoders.

The strengths of the R&S UPL become evident especially in mobile use. The unit is compact and lightweight and requires no additional equipment. Results are stored in the built-in PC and thus available for later use. Routine measurements can be repeated easily using stored instrument settings.



- ◆ Built-in hard disk and disk drive
- ◆ Connectors for keyboard, mouse, monitor, printer and plotter
- ◆ Centronics interface for connecting printer or network
- ◆ Drivers for commercial printers supplied as standard
- ◆ Remote control via IEC/IEEE bus or RS-232-C interface
- ◆ Postprocessing of results directly in the R&S UPL using standard software
- ◆ All results available in the common data formats, making it easy to import graphics into documents, for example
- ◆ Easy loading of function and software extensions via floppy disk
- ◆ Automatic test sequences and measurement programs with universal sequence controller, plus easy generation of programs with built-in program generator

Everything in one package

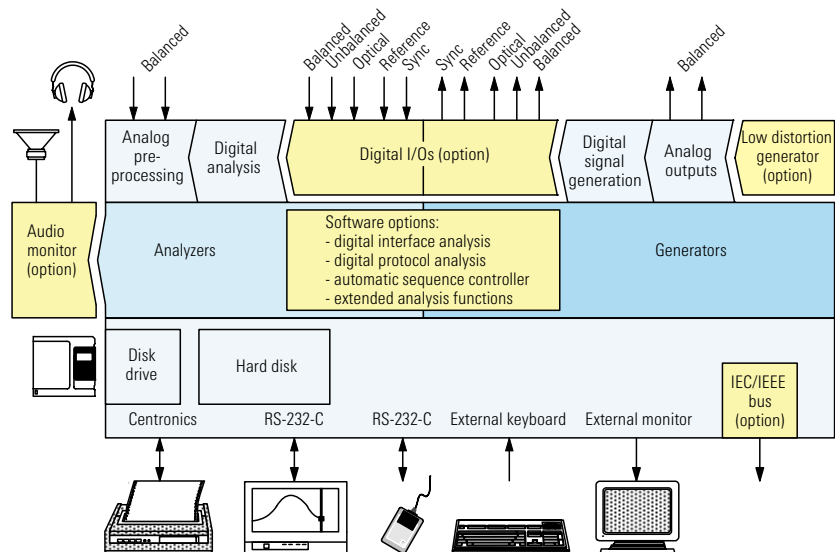
The Audio Analyzer R&S UPL is a compact unit with an integrated controller. It avoids the disadvantages of external PC control found in other audio analyzers. The instrument is easy to transport as it requires no external equipment such as keyboard, monitor or other PC peripherals.

The R&S UPL is supplied ready for use. Installation merely consists of unpacking the unit and switching it on to start the measurement. The user is not burdened with problems that cropped up in the past with the installation of interface cards or PC software.

With audio analyzers controlled from an external PC, interference may be radiated from the PC, the monitor or interface connections, which distorts measurement results. Not so with the R&S UPL: the instrument has specified EMC characteristics which also include the internal PC. In contrast to conventional PCs, the R&S UPL provides elaborate screening features such as magnetically shielded power transformers and a coated filter pane in front of the display.

And the icing on the cake: the price of the R&S UPL includes the internal PC.

Block diagram of R&S UPL.



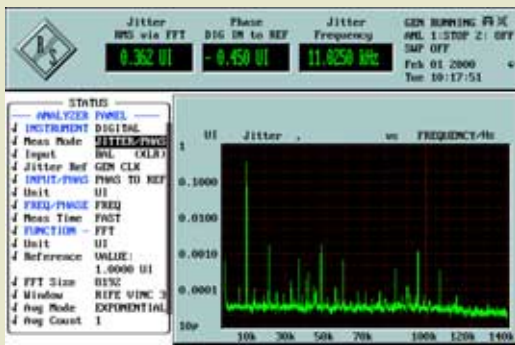


Fig. 9: Individual interference components can easily be found with the aid of the jitter spectrum.

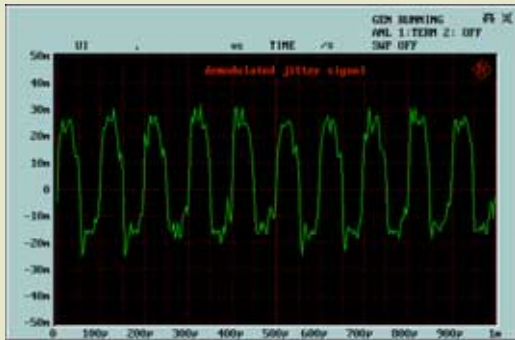


Fig. 10: Display of jitter signal in time domain.



Fig. 11: Complete measured-value tables can be output for all functions.



Fig. 12: The R&S UPL generates and analyzes additional data in digital data streams in line with all common standards. The data is represented in binary form, as hexadecimal numbers, or as ASCII characters, or it is evaluated in consumer or professional format.

Interfaces, protocol analysis, jitter

Analog interfaces

- ◆ Balanced inputs with high common-mode rejection and various types of impedance commonly used in the studio. Measurements can be made on lines with phantom feed.
- ◆ Balanced outputs, floating (e.g. to prevent hum loops).
- ◆ The generator outputs can be internally connected to the analyzer inputs so that different types of measurement can be performed without changing the cabling.

Digital audio interfaces (options R&S UPL-B2 and R&S UPL-B29)

- ◆ Balanced (XLR), unbalanced (BNC) and optical (TOSLINK) inputs and outputs for connecting consumer electronics and professional studio equipment are provided.
- ◆ The levels of the balanced and unbalanced outputs are adjustable so that the sensitivity of digital audio inputs can be determined.
- ◆ The format of the generated channel status data may be professional or consumer regardless of the selected interface.
- ◆ A reference (XLR) and a synchronization (BNC) input provided on the rear panel allow both the analyzer and the generator to be synchronized to the digital audio reference signal (DARS) in line with AES 11; in addition the generator can be synchronized to wordclock, video sync signals (PAL/SECAM/NTSC) and 1024 kHz reference clocks.
- ◆ Both generator and analyzer can be operated at clock rates of 35 kHz to 106 kHz. The clock signal can also be produced internally by the generator.
- ◆ The clock rates of the analyzer and generator are independent of each other. This allows measurements on sample rate converters.

- ◆ The word length can be selected independently for generator and analyzer between 8 and 24 bits.



Improvement of audio quality of sound cards and multimedia equipment – a task for the R&S UPL.

Digital protocol analysis and generation (option R&S UPL-B21)

This software option extends the functions of options R&S UPL-B2 and R&S UPL-B29 by an in-depth analysis and generation of additional digital data:

- ◆ Analysis of channel status and user data. The data is output in binary form, as hexadecimal numbers, or as ASCII characters, or, in the case of channel status data, it is evaluated in the professional or consumer format in line with AES 3 or IEC 958 (Fig. 12).

- ◆ Generation of channel status data, user data and validity bits. Channel status data can be entered in binary form or via panel in line with AES 3 or IEC 958 using the professional or consumer format.
- ◆ Any bits can be combined under a symbolic name. In this way, data input and representation can easily be adapted to customer requirements.
- ◆ Simultaneous measurement of clock rate and display of interface errors (such as parity error).

Jitter and Interface Tests (option R&S UPL-B22)

The physical parameters of digital audio interfaces can be evaluated with this option. The R&S UPL-B22 extends the functions of options R&S UPL-B2 and R&S UPL-B29.

Signal analysis:

- ◆ Measurement of jitter amplitude and display of jitter signal in the frequency and time domain (Figs 9 and 10).
- ◆ The R&S UPL generates bit- or word-synchronous sync signals that allow the accurate display of digital audio signals on an oscilloscope (preamble, eye pattern, signal symmetry, superimposed noise, etc).
- ◆ Measurement of input pulse amplitude and sampling frequency.
- ◆ Measurement of phase difference between audio and reference input signal.
- ◆ Measurement of time difference between output and input signal. This allows delay times of equalizers, audio mixers, etc to be measured.
- ◆ Analysis of common-mode signal of balanced input (frequency, amplitude, spectrum).

Digital components of various data formats and clock rates are the stock-in-trade of professional users, who need a measuring instrument offering top performance on all interfaces with high accuracy and over a wide dynamic range. Operation is identical for analog and digital interfaces, which enhances operator convenience. Fast fault diagnosis is possible by means of stored test routines, allowing the elimination of problems immediately before transmission.



Signal generation:

- ◆ The clock of the output signal can be “jittered” by superimposing a sine-wave or noise signal of variable amplitude.
- ◆ When generating digital audio data – with option R&S UPL-B1 installed – jitter and common-mode interference can be added to the data stream.
- ◆ An input signal with jitter can be output jitter-free.
- ◆ A common-mode signal can be superimposed on the balanced output signal.
- ◆ Long cables can be simulated by means of a switchable cable simulator.
- ◆ The phase shift between the digital audio output and the reference output can be varied.

Generation of coded audio signals (option R&S UPL-B23)

With this option, the Audio Analyzer R&S UPL is able to generate AC-3-coded test signals (other data formats soon available) directly with the integrated generator, e.g. to measure surround sound decoders.

The number of channels, frequency or level sweep, start and stop frequency/level as well as the number of sweep points can be set, thus allowing flexible test sequence combinations.

The measurements are automatically synchronized between generator and analyzer.

The R&S UPL-B23 requires options R&S UPL-B2 or R&S UPL-B29. For more information refer to data sheet PD 0757.6985, Multichannel audio measurements on surround sound decoders.

Designed for convenience

Efficient online help

The R&S UPL offers a variety of help features:

HELP function

HELP information in German or English can be called up for each input field.

SHOW I/O key

If results cannot be displayed, e.g. because an input signal is either missing or incorrect, information on possible causes will appear upon pressing SHOW I/O. Moreover, the input and output configuration will be displayed.

Info boxes

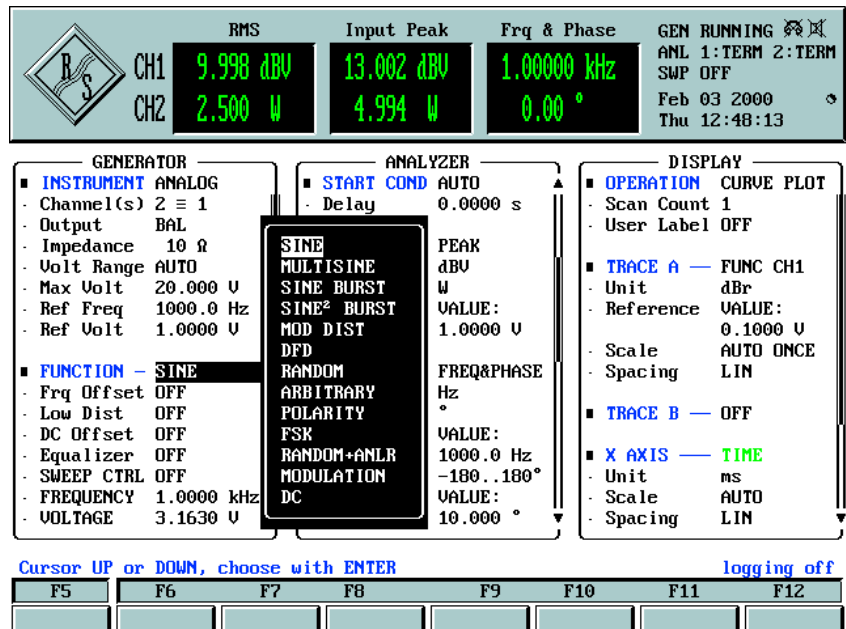
These highlighted boxes indicate any incorrect settings.

Online help

The permissible range of values is indicated for each menu item requiring the entry of a numeric value. This range takes into account any limitations resulting from related parameters, e.g. the sample rate in the case of measurements on digital interfaces.

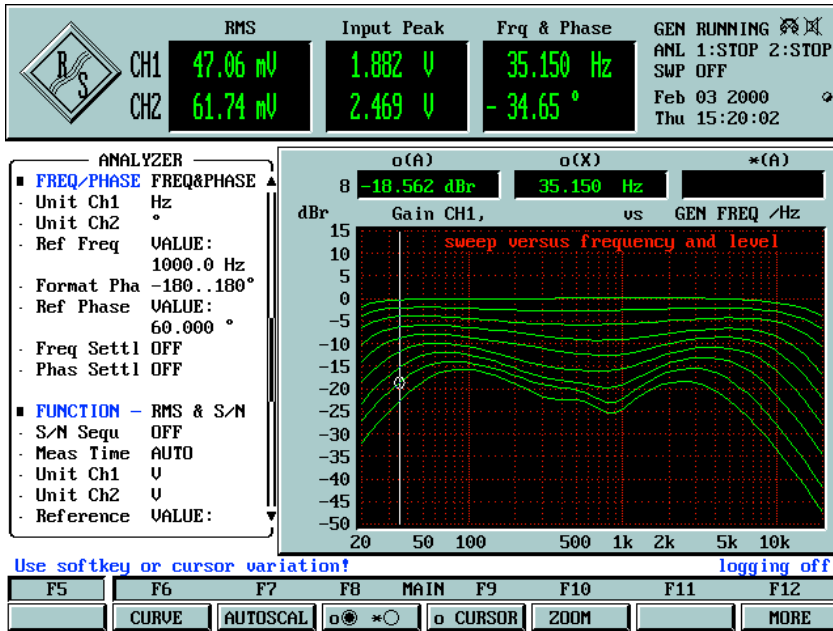
Protection against invalid entries

The R&S UPL will not accept entries outside the permissible range. An alarm tone will be issued and the value changed to the permissible minimum or maximum value.



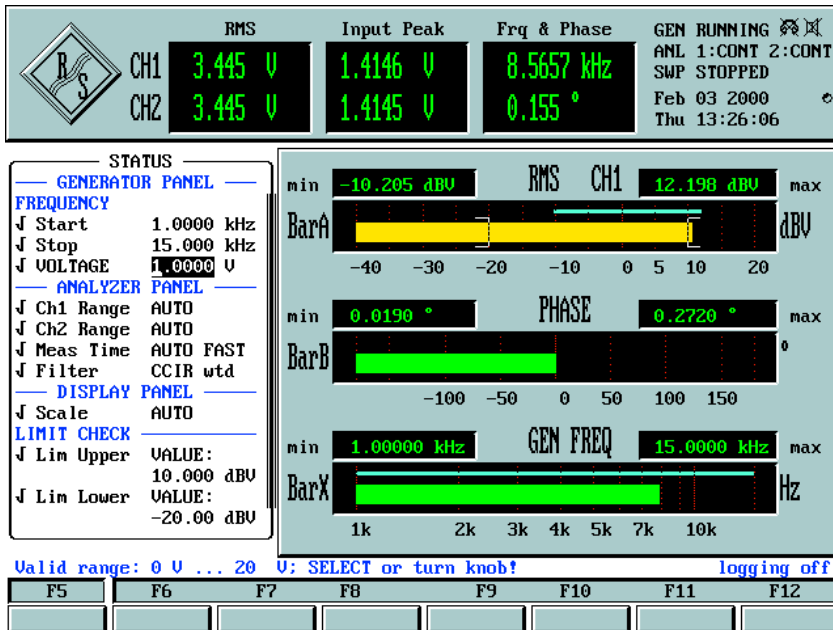
A wealth of functions – yet easy to operate

- ◆ Related functions and settings are combined in panels that can be called up at a keystroke. Up to three panels can be displayed at a time.
- ◆ The operator is not burdened with unnecessary information. Only the parameters and settings needed for a specific application are displayed – the others are available in the background. (For example, the sweep parameters are transferred to the generator panel and displayed only when the sweep function is activated.)
- ◆ Fast access to frequently used instrument setups and a comprehensive library of standard measurements make the instrument easy to learn.
- ◆ Straightforward data entry: the user simply needs to open a menu and make an entry or selection.
- ◆ Continuously updated status information on generator, analyzer and sweep.
- ◆ Quick operating sequences through the use of softkeys, e.g. for graphical representations.
- ◆ The user can choose between operation via mouse, external keyboard or front panel. This choice is important since the working space required by a mouse is not always available.
- ◆ Short learning time due to an easy-to-understand operating concept that treats analog and digital measurements in the same manner.



Results at a glance

- ◆ Realtime display of results for one or both channels and several test functions.
- ◆ Simultaneous display of frequency and phase.
- ◆ With graphics, results can be read off with vertical and horizontal cursors. Tolerance curves or stored results can be added for comparison.
- ◆ Sets of traces can be displayed, stored and evaluated for both channels.
- ◆ Graphics options include traces and bargraphs, spectrum display, and three-dimensional waterfalls.



In many cases only a few parameters need to be modified after a measurement sequence has been started. Therefore, entry lines can be selected from the input panels for the generator, analyzer, etc. by means of a checkmark. They are then transferred to a status panel. The status panel thus gives a summary of parameters for a measurement routine, which offers the following advantages:

- ◆ Instrument settings can be displayed together with graphical and numerical results.
- ◆ All important information can be printed on a single hardcopy.
- ◆ Instrument settings can be modified quickly without changing panels as the R&S UPL can also be operated from the status panel.

Fast and efficient

High measurement speed

In designing the Audio Analyzer R&S UPL, particular emphasis was placed on optimizing the measurement speed of the test system as a whole:

- ◆ All operations involving extensive number crunching are carried out by digital signal processors. The PC is merely used for controlling the unit and displaying results.
- ◆ The R&S UPL can perform even complex test functions simultaneously on both channels. This feature alone reduces the time for stereo measurements by 50% compared to most analyzers available on the market.
- ◆ The digital test routines adapt their speed optimally to the input frequency. This enhances measurement speed especially in the case of frequency sweeps.
- ◆ The R&S UPL performs harmonic distortion and IMD measurements using patented, digital test procedures that combine high accuracy with high measurement speed.
- ◆ Digital signal processing reduces setting and transient times achievable with purely analog instruments. These times are also taken into account in the test routines, yielding stable measurements without the need for activating settling functions (these are understood to be repeated measurements until results are within a tolerance band).

- ◆ The user interface was tailored to the requirements of a test environment, not an office one.
- ◆ Display windows not needed can be switched off, which also reduces the processing time. When all displays are switched off and results are output via the IEC/IEEE bus, more than 100 level measurements per second can be performed.

Use in production

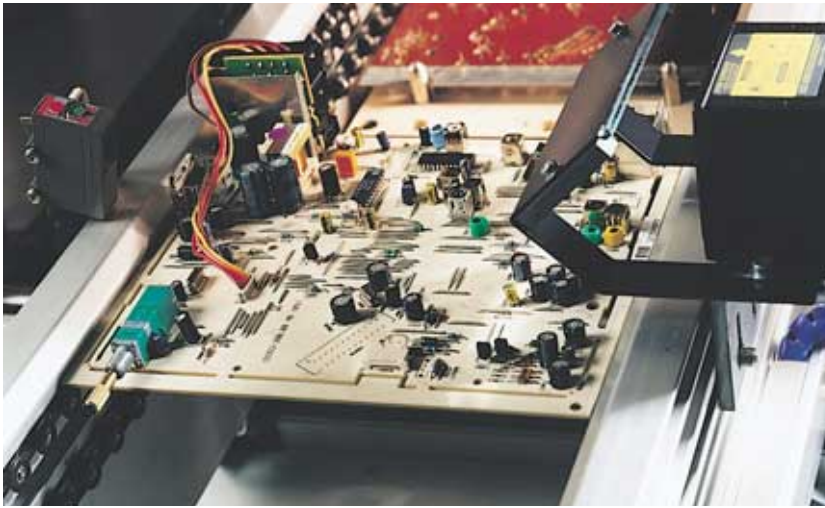
Instruments to be used in production tests must satisfy a variety of requirements:

- ◆ High measurement speed is vital for achieving a high production throughput. By making appropriate use of the instrument functions, go/no-go decisions can already be made in the audio analyzer, thus reducing the run time of a DUT (Fig. 8).

- ◆ Two-channel measurements allow the simultaneous and thus time-saving determination of input and output characteristics.
- ◆ The use of FFT analysis provides a decisive advantage especially in the case of frequency response measurements, which are particularly time-critical (example: approx. 900 frequency values in 150 ms).
- ◆ Long calibration intervals, resulting from the extensive use of digital circuits, make for high availability of the instrument.
- ◆ The R&S UPL66 model is specially tailored to the requirements of production. It comes without a display and keypad, thus holding down costs. Yet the unit can be operated manually by connecting a PC keyboard and a VGA monitor, enabling fast fault localization in the event of production problems.

The R&S UPL66 – special model for use in test systems, with the full flexibility of the standard model.





High measurement speed, two-channel measurements and remote-control capability via the IEC/IEEE bus are a must in production systems. The long calibration intervals of the R&S UPL make for high availability and reduce costs.

◆ Remote-control capability via the IEC/IEEE bus is a must in large-scale production systems. In the design of the Audio Analyzer R&S UPL, special importance was attached to data transfer via the IEC/IEEE bus. The logging mode can be used to speed up the generation of control programs for the IEC/IEEE bus. With the program generator provided in the R&S UPL-B10, it is no longer necessary to look up IEC/IEEE bus commands.

Universal Sequence Controller R&S UPL-B10

The R&S UPL-B10 is used to generate and execute measurement sequences, thus turning the R&S UPL into an automatic test system.

Measurement sequence programming is greatly facilitated by the built-in program generator: Each manual control step is recorded in the logging mode and translated into a complete line of the sequence program with correct syntax, i.e. test sequences can be programmed without the user typing a single line. The generated program does not just specify the sequence of keys to be pressed but contains the instructions in easy-to-read IEC/IEEE bus syntax according to SCPI.

BASIC commands can then be used to modify the program, e.g. for branching or graphic outputs.

Complete application programs based on the universal sequence controller are available for measurements on CD players, tuners, etc.

The universal sequence controller can also be used for remote control of external equipment via the IEC/IEEE bus or the RS-232-C interface. Moreover, programs generated on the R&S UPL can be transferred to an external controller after slight modifications for the remote control of the R&S UPL. This greatly facilitates the generation of remote-control programs.



Test assemblies for electroacoustic converters frequently consist of microphones and loudspeakers, whose frequency response must be compensated. The equalizer function of the R&S UPL furnishes tailor-made solutions for such tests. Comprehensive test routines can be implemented with the aid of the universal sequence controller.

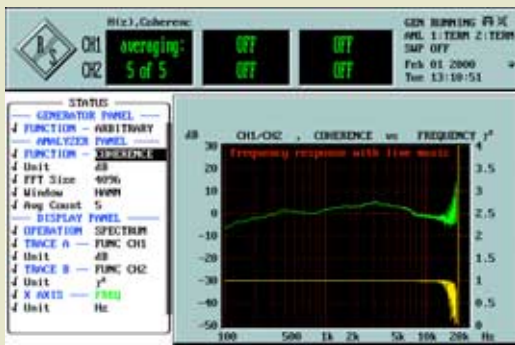


Fig. 13: Transfer and coherence function for determining the transfer characteristic with the aid of complex test signals (e.g. music or voice).

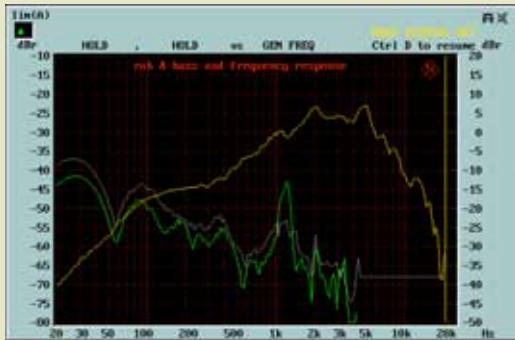


Fig. 14: Frequency response and rub & buzz function for quality assurance in loudspeaker production.

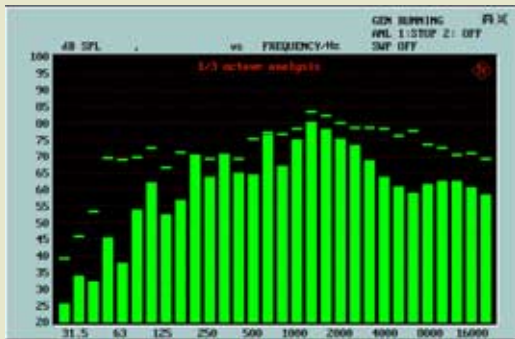


Fig. 15: Third-octave analysis used mainly in acoustics.

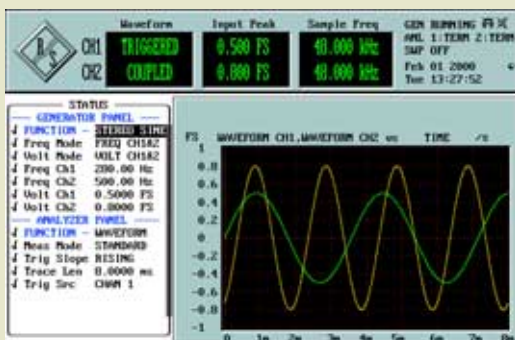


Fig. 16: Different signals for both channels may be generated at the digital audio outputs.

Options and further applications

Low Distortion Generator R&S UPL-B1

This option is essential for all applications requiring extremely pure analog signals or an extended frequency range up to 110 kHz.

When digital audio data is produced by the universal generator, the low distortion generator may generate an analog signal or be used for superimposing jitter or common-mode interference.

Digital Interfaces R&S UPL-B2/-B29

These options contain the digital audio interfaces (balanced, unbalanced and optical) for the standard sampling rates 44.1 kHz and 48 kHz, and the R&S UPL-B29 also covers the extended rates up to 96 kHz. Either the R&S UPL-B2 or the R&S UPL-B29 can be installed. A detailed description of these options and their software extensions (Digital Audio Protocol R&S UPL-B21, Jitter and Interface Tester R&S UPL-B22 as well as the Coded Audio Signal Generation R&S UPL-B23) can be found on pages 8 and 9.

Audio Monitor R&S UPL-B5

This option adds a headphone output and a built-in loudspeaker to the R&S UPL. The input signal and – in the case of level, THD+N and rub & buzz measurements – the filtered or weighted signal can be monitored.

Extended Analysis Functions R&S UPL-B6

In modern audio systems, the transfer characteristics are dynamically adapted to the input signals. When conventional, static test signals are used as input signals, the dynamic processes are not activated and thus the signals cannot be analyzed. The **coherence and transfer functions** are the solution to this problem:

speech, music, noise, etc. are used as test signals, and the transfer characteristic is represented by analyzing the output spectrum referenced to the input spectrum (Fig. 13). The required complex test signals stored in various formats can be directly called from the R&S UPL hard disk.

With the **rub & buzz measurement**, manufacturing defects of loudspeakers can be found in no time by measuring the unwanted signals in the frequency range above that of typical distortion products (Fig. 14).

The **third-octave analysis** is an important measurement in acoustics. The levels of up to 32 third-octave bands are simultaneously measured in compliance with class 0 of IEC 1260 (Fig. 15).

In multitone signal generation, the R&S UPL-B6 also allows the phase and crest factor to be set. The R&S UPL-B6 is also required for generating two-channel sine-wave signals at the digital outputs (Fig. 16).

Further functional extensions of the R&S UPL-B6 are currently being developed.

Hearing Aids Test Accessories R&S UPL-B7

The Audio Analyzer R&S UPL with the option R&S UPL-B7 forms a complete test system for all standard measurements on hearing aids. The R&S UPL merely needs to be equipped with options R&S UPL-B5 and R&S UPL-B10. The R&S UPL-B7 includes an acoustic test chamber as well as all accessories required for measurements on hearing aids such as battery adapters, connecting cables and acoustic

couplers. The associated software enables complete measurements in accordance with IEC60118 or ANSI S3.22. *)

Acoustic measurements on GSM mobile phones with the R&S UPL 16 or option R&S UPL-B8/-B9

The acoustic transmission and reproduction quality of a mobile phone is the most important characteristic in everyday use. The **Audio Analyzer R&S UPL16** was developed for conformance tests on GSM mobiles. It performs all audio measurements in line with chapter 30 of GSM 11.10 and 3GPP TS 51.010 Release 99, phase 2. Access to the internal digital signals of special test mobile phones is via the standard digital audio interface (DAI).

Network operators, consumer test institutes, etc, are particularly interested in measuring and comparing acoustic char-



acteristics of commercial mobiles. A highly accurate test method is also required for quality assurance and sampling inspection in the production of mobile phones.

The **Mobile Phone Test Set R&S UPL-B8** is available for these applications. With the aid of this option all necessary audio measurements can be performed on GSM mobile phones without the DAI interface. The **3G Mobile Phone Tests R&S UPL-B9** provide the same functionality, but expanded to 3G mobile phones and to the latest 3GPP specifications TS26.131 and 132. These tests are validated and can therefore be used for type approvals. R&S UPL-B8 and -B9 require options R&S UPL-B6 and -B10. For further information refer to data sheet PD 0757.5889, Acoustic Test of GSM Mobiles.

The **Automatic Audio Line Measurement to ITU-T 0.33, R&S UPL-B33** performs automatic measurements of all relevant parameters of broadcast links according to ITU-T 0.33. The generator and analyzer are normally located at different sites. Operators may utilize the standard sequences defined by ITU-T 0.33 or prepare their own. Option R&S UPL-B10 is needed for the use of the R&S UPL-B33.

The **Remote Control R&S UPL-B4** enables remote control of R&S UPL via the RS-232-C interface or IEC625/IEEE488 interface. The commands largely meet SCPI standards.

The **Universal Sequence Controller R&S UPL-B10** allows measurement sequences to be generated and executed. For detailed information see page 13.

With option **LAN Interface R&S UPL-B11**, the Audio Analyzer R&S UPL can be connected to Novell networks in line with 10/100 BASE-T standard in order, for example, to exchange data or access the network printer (not for R&S UPL16).

The **150 Ω Modification R&S UPL-U3** changes the source impedance of the analog generator from 200 Ω to 150 Ω.

*) For further information on this application refer to data sheet PD 0757.2696, Test System R&S UPL + R&S UPL-B7 for Hearing Aids.



Measurements on hearing aids.

Specifications

Analog analyzers

For analog measurements two analyzers with different bandwidths, specifications and measurement functions are available:

Analyzer	Frequency range
ANLG 22 kHz	DC/10 Hz to 21.90 kHz ¹⁾
ANLG 110 kHz	DC/20 Hz to 110 kHz ¹⁾
Level measurements (rms)	
Accuracy at 1 kHz	±0.05 dB
Frequency response (ref. to 1 kHz)	
20 Hz to 22 kHz	±0.03 dB, typ. 0.003 dB ($V_{in} < 3$ V)
10 Hz to 20 Hz	±0.1 dB
22 kHz to 50 kHz	±0.1 dB
50 kHz to 110 kHz	±0.2 dB

Inputs

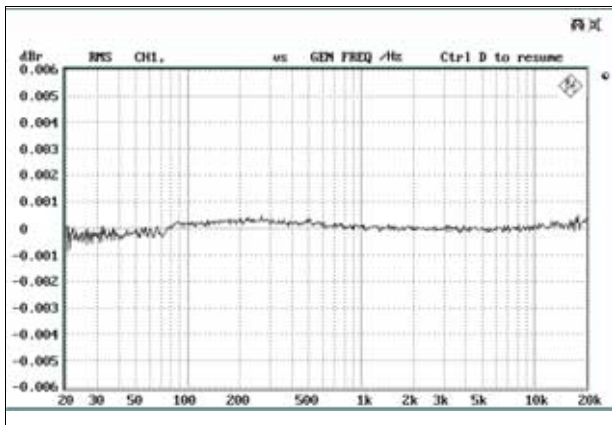
XLR connectors

2 channels, balanced (unbalanced measurements possible with XLR/BNC Adapter R&S UPL-Z1), floating/grounded and AC/DC coupling switchable
 0.1 μ V to 110 V (rms, sine)
 18 mV to 100 V, in steps of 5 dB
 100 k Ω ±1% shunted by 120 pF, each pin against ground
 300 Ω , 600 Ω , ±0.5% each, P_{max} 1 W
 >120 dB, frequency <22 kHz, 600 Ω
 >100 dB at 50 Hz,
 >86 dB at 1 kHz, >80 dB at 16 kHz
 each input channel switchable to the other output channel, input impedance: balanced 200 k Ω , unbalanced 100 k Ω

Voltage range
 Measurement ranges
 Input impedance

Crosstalk attenuation
 Common-mode rejection ($V_{in} < 3$ V)

Generator output



Typical frequency response, measured with internal generator/analyzer at analog interfaces

Measurement functions

RMS value, wideband

Accuracy	
Measurement speed	
AUTO	±0.05 dB at 1 kHz, sine
AUTO FAST	±0.1 dB additional error
Integration time	
AUTO FAST/AUTO VALUE	4.2 ms/42 ms, at least 1 cycle
GEN TRACK	1 ms to 10 s
Noise (600 Ω)	2.1 ms, at least 1 cycle
with A filter	1 μ V
with CCIR unweighting filter	<2 μ V, 1.6 μ V typ. (ANLG 22 kHz)

¹⁾ DC/AC coupling.

Filter
 weighting filters and user-definable filters, up to 3 filters can be combined, analog notch filter in addition (expansion of dynamic range by up to 30 dB) post-FFT of filtered signal

Spectrum

RMS value, selective

Bandwidth (−0.1 dB)
 1%, 3%, 1/12 octave, 1/3 octave and user-selectable fixed bandwidth, minimum bandwidth 20 Hz
 Selectivity
 100 dB (80 dB) with analyzer ANLG 22 kHz (110 kHz) bandpass or bandstop filter, 8th order elliptical filter, analog notch filter in addition
 Frequency setting
 – automatic to input signal
 – coupled to generator
 – fixed through entered value
 – sweep in selectable range
 Accuracy
 ±0.2 dB + ripple of filters

Peak value

Measurement
 with analyzer ANLG 22 kHz only
 peak max, peak min, peak-to-peak, peak absolute
 Accuracy
 ±0.2 dB at 1 kHz
 Interval
 20 ms to 10 s
 Filter²⁾
 weighting filters and user-definable filters, up to 3 filters can be combined

Quasi-peak

Measurement, accuracy
 with analyzer ANLG 22 kHz only
 Noise (600 Ω)
 Filter²⁾
 <8 μ V with CCIR weighting filter
 weighting filters and user-definable filters, up to 3 filters can be combined, analog notch filter in addition

DC voltage

Voltage range
 0 V to ±110 V
 Accuracy
 ±(1% of measured value + 0.1% of measurement range)

Measurement ranges
 100 mV to 100 V, in steps of 10 dB

S/N measurement routine

available for measurement functions
 – rms, wideband
 – peak
 – quasi-peak
 indication of S/N ratio in dB, no post-FFT

FFT analysis

see FFT analyzer section

Total harmonic distortion (THD)

Fundamental
 10 Hz to 22 kHz
 Frequency tuning
 automatic to input or generator signal or fixed through entered value
 Weighted harmonics
 any combination of d_2 to d_9 , up to 110 kHz

Accuracy

Harmonics	<50 kHz	±0.5 dB
	<110 kHz	±0.7 dB

Inherent distortion^{3/4)}

Analyzer ANLG 22 kHz	
Fundamental	20 Hz to 10.95 kHz
	10 Hz to 20 Hz
	<−110 dB, typ. −115 dB
	<−100 dB

Analyzer ANLG 110 kHz	
Fundamental	50 Hz to 20 kHz
	<−100 dB, typ. −105 dB

Spectrum
 bar chart showing signal and distortion

THD+N and SINAD

Fundamental
 10 Hz to 22 kHz
 Frequency tuning
 automatic to input or generator signal or fixed through entered value
 Input voltage
 typ. >100 μ V with automatic tuning
 Bandwidth
 upper and lower frequency limit selectable, one weighting filter in addition

²⁾ With R&S UPL-B29 only in base rate mode.

³⁾ Total inherent distortion of analyzer and generator (with option R&S UPL-B1), analyzer with dynamic mode precision.

⁴⁾ >3.5 V: typ. 3 dB less; <0.5 V: sensitivity reduced by inherent noise (typ. 0.25/1.25 μ V with analyzers 22/110 kHz).

Accuracy		
Bandwidth	<50 kHz	±0.5 dB
	<100 kHz	±0.7 dB
Inherent distortion ¹⁾		
Analyzer ANLG 22 kHz		
Bandwidth	20 Hz to 21.90 kHz	typ. -110 dB at 1 kHz, 2.5 V <-105 dB +2 µV ²⁾ typ. -108 dB +1.5 µV
Analyzer ANLG 110 kHz		
Bandwidth	20 Hz to 22 kHz 20 Hz to 110 kHz	<-95 dB + 2.5 µV, typ. -100 dB +1.75 µV <-88 dB + 5 µV, typ. -95 dB + 3.5 µV post-FFT of filtered signal
Spectrum		

Modulation factor (MOD DIST)

Measurement method		selective to DIN IEC 268-3
Frequency range		lower frequency 30 Hz to 2700 Hz upper frequency 8 x LF to 100 kHz ³⁾
Accuracy		±0.50 dB
Inherent distortion ⁴⁾		
Upper frequency	4 kHz to 15 kHz 15 kHz to 20 kHz	<-96 dB (-90 dB), typ. -103 dB <-96 dB (-85 dB)
Spectrum		bar chart showing signal and distortion

Difference frequency distortion (DFD)

Measurement method		selective to DIN IEC 268-3 or 118
Frequency range		difference frequency 80 Hz to 2 kHz center frequency 200 Hz to 100 kHz ⁵⁾
Accuracy		±0.50 dB, center frequency <20 kHz
Inherent distortion ⁶⁾	DFD d ₂ DFD d ₃	<-112 dB, typ. -125 dB <-96 dB, typ. -105 dB
Spectrum		bar chart showing signal and distortion

Wow and flutter

Measurement method		with analyzer ANLG 22 kHz only DIN/IEC, NAB, JIS, 2-sigma to IEC-386
Weighting filter	OFF ON	highpass 0.5 Hz, bandwidth 200 Hz bandpass 4 Hz to IEC-386
Accuracy		±3%
Inherent noise		<0.0005% weighted <0.001% unweighted
Spectrum		post-FFT of demodulated signal

Time domain display (WAVEFORM)

Trigger		rising/falling edge
Trigger level		-200 V to +200 V, interpolated between samples
Trace length		max. 7424 points
Standard mode		1- to 32-fold interpolation
Compressed mode		2- to 1024-fold compression (envelope for AGC measurement), with analyzer ANLG 22 kHz only

Frequency⁷⁾

Frequency range	20 Hz to 110 kHz
Accuracy	±50 ppm

Phase⁷⁾

Frequency range	with analyzer 22 kHz only 20 Hz to 20 kHz
Accuracy	±0.5°

Group delay⁷⁾

Frequency range	with analyzer 22 kHz only 20 Hz to 20 kHz
Accuracy in seconds	$\Delta\phi/(\Delta f \times 360)$, where $\Delta\phi$ = phase accu- racy in °, Δf = frequency step

¹⁾ Total inherent distortion of analyzer and generator (with option R&S UPL-B1), analyzer with dynamic mode precision.

²⁾ At full-scale level of measurement range (<-100 dB + 2 µV with auto range), <-100 dB for input voltage >3.5 V.

³⁾ For upper frequency >20 kHz, the bottom limit of lower frequency is reduced.

⁴⁾ Input voltage >200 mV, typical values apply between 0.5 V and 3.5 V.

Lower frequency >200 Hz, values in () for lower frequency <200 Hz.

Dynamic mode precision; level ratio LF:UF = 4:1.

⁵⁾ For center frequencies >20 kHz the bottom limit of the difference frequency is reduced.

⁶⁾ Input voltage >200 mV, typical values apply between 0.5 V and 3.5 V, dynamic mode precision (at DFD d2), center frequency 7 kHz to 20 kHz.

⁷⁾ With measurement functions RMS, FFT and THD+N only, accuracy applies to 8k FFT with zoom factor 2, Rife-Vincent-2 window; S/N ratio >70 dB.

Polarity test

Measurement	polarity of unsymmetrical input signal
Display	+POL, -POL

Analog generators

An 18-bit $\Delta\Sigma$ D/A converter is used for analog signal generation. The characteristics of the basic generator can be improved and extended with a low-distortion RC oscillator (Low Distortion Generator R&S UPL-B1):
– sine with reduced distortion
– frequency range up to 110 kHz

Outputs

XLR connectors, 2 channels, floating, balanced/unbalanced switchable, short-circuit-proof; max. current <120 mA with external feed

Balanced

Voltage	0.1 mV to 20 V (rms, sine, open-circuit)
Crosstalk attenuation	>115 dB, frequency <20 kHz
Source impedance	typ. 10 Ω, 200 Ω (150 Ω with R&S UPL-U3) ±0.5%, 600 Ω ±0.5%
Load impedance	>400 Ω (incl. source impedance)
Output balance	>75 dB at 1 kHz, >60 dB at 20 kHz

Unbalanced

Voltage	0.1 mV to 10 V (rms, sine, open-circuit)
Crosstalk attenuation	>115 dB, frequency <20 kHz
Source impedance	5 Ω
Load impedance	>200 Ω

Signals

Sine

Frequency range	2 Hz to 21.75 kHz
Frequency accuracy	±50 ppm
Level accuracy	±0.1 dB at 1 kHz
Frequency response (ref. to 1 kHz)	
20 Hz to 20 kHz	±0.05 dB
Inherent distortion THD+N	
Measurement bandwidth	
20 Hz to 22 kHz	<-94 dB, typ. -98 dB
20 Hz to 100 kHz	<-86 dB
Sweep parameters	frequency, level

Sine (with low distortion generator option)

Frequency range	10 Hz to 110 kHz
Frequency accuracy	±0.5% at 15°C to 30°C ±0.75% at 5°C to 45°C ±0.1 dB at 1 kHz
Level accuracy	
Frequency response (ref. to 1 kHz)	
20 Hz to 20 kHz	±0.05 dB
10 Hz to 110 kHz	±0.1 dB
Harmonics	typ. <-115 dB (<-120 dB at 1 kHz), measurement bandwidth 20 Hz to 20 kHz, voltage 1 V to 5 V

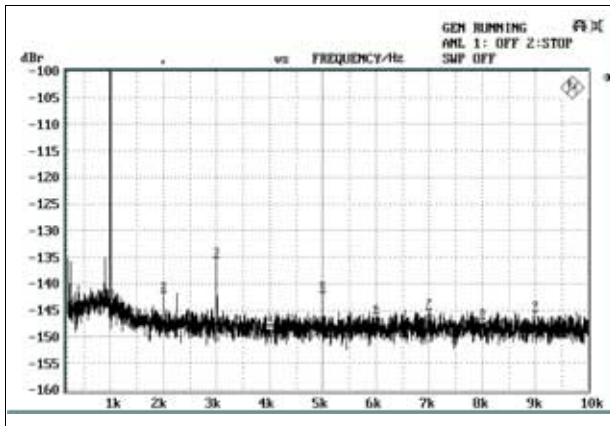
Inherent distortion (THD)

Fundamental 1 kHz, 1 V to 10 V	<-120 dB typ.
20 Hz to 7 kHz	<-105 dB
7 kHz to 20 kHz	<-100 dB

Inherent distortion (THD+N)⁸⁾

Fundamental 1 kHz, 2.5 V	-110 dB typ.	Meas. bandw.
20 Hz to 20 kHz	<-100 dB +2 µV	22 kHz
20 Hz to 20 kHz	<-88 dB +5 µV	100 kHz
Sweep parameters	frequency, level	

⁸⁾ Total inherent distortion of analyzer and generator, analyzer with dynamic mode precision.



Typical spectrum of low distortion generator at 1 kHz, 1 V

MOD DIST

Frequency range	lower frequency upper frequency	for measuring the modulation distortion 30 Hz to 2700 Hz 8 x LF to 21.75 kHz selectable from 10:1 to 1:1
Level ratio (LF:UF)		±0.5 dB
Level accuracy		< -94 dB (typ. -100 dB) at 7 kHz, 60 Hz < -84 dB (typ. -90 dB), level ratio LF:UF = 4:1
Inherent distortion		upper frequency, level
Sweep parameters		

DFD

Frequency range	difference freq. center frequency	for measuring the difference tone 80 Hz to 2 kHz 200 Hz to 20.75 kHz
Level accuracy		±0.5 dB
Inherent distortion ¹⁾	DFD d ₂ DFD d ₃	< -114 dB, typ. -120 dB < -92 dB, typ. -100 dB
Sweep parameters		center frequency, level

Multi-sine

Frequency range		2.93 Hz to 21.75 kHz
Frequency spacing		adjustable from 2.93 Hz
Frequency resolution		< 0.01% or matching FFT frequency spacing
Dynamic range		100 dB, referred to total peak value
Characteristics		
Mode 1		1 to 17 spectral lines – level and frequency selectable for each line – phase of each component optimized for minimum crest factor – phase of each component or crest factor selectable (with R&S UPL-B6)
Mode 2		1 to 7400 spectral lines (noise in frequency domain), distribution: white, pink, 1/3 octave, defined by file; crest factor selectable (with R&S UPL-B6)

Sine burst, sine² burst

Burst time		1 sample up to 60 s, 1-sample resolution
Interval		burst time up to 60 s, 1-sample res.
Low level		0 to burst level, absolute or relative to burst level (0 with sine ² burst)
Bandwidth		21.75 kHz (elliptical filter)
Sweep parameters		burst frequency, level, time, interval

Noise

Distribution		Gaussian, triangular, rectangular
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Arbitrary waveform

File format		loaded from file
*.TTF (internal)		memory depth max. 16 k
*.WAV ²⁾		reproduction of audio files (mono), duration approx. 10 s per Mbyte RAM
Clock rate		48 kHz
Bandwidth		21.75 kHz (elliptical filter)

¹⁾ Center frequency >5 kHz, difference frequency <1 kHz; DFD d₂ -100 dB (typ.) with DC offset.

²⁾ With R&S UPL-B29 only in base rate mode.

Polarity test signal

Sine² burst with following characteristics:

Frequency	1.2 kHz
On-time	1 cycle (0.8333 ms)
Interval	2 cycles (1.6667 ms)

FM signal

Carrier frequency	2 Hz to 21.75 kHz
Modulation frequency	1 mHz to 21.75 kHz
Modulation	0% to 100%

AM signal

Carrier frequency	2 Hz to 21.75 kHz
Modulation frequency	1 mHz to 21.75 kHz
Modulation	0% to 100%

DC voltage

Level range	0 V to ±10 V (±5 V unbalanced), sweep possible
Accuracy	±2%

DC offset³⁾

Accuracy	0 V to ±10.0 V (±5 V unbalanced) ±2%
Residual offset	<1% of rms value of AC signal

Digital analyzer (option R&S UPL-B2 or -B29)

Frequency limits specified for measurement functions apply to a sampling rate of 48 kHz. For other sampling rates limits are calculated according to the formula:
 $f_{\text{new}} = f_{48 \text{ kHz}} \times \text{sampling rate}/48 \text{ kHz}$.

Inputs

Balanced input	XLR connector, transformer coupling
Impedance	110 Ω
Level (V _{pp})	min. 200 mV, max. 12 V
Unbalanced input	BNC, grounded
Impedance	75 Ω
Level (V _{pp})	min. 100 mV, max. 5 V
Optical input	TOSLINK
Channels	1, 2 or both
Audio bits	8 to 24
Clock rate	35 kHz to 55 kHz with R&S UPL-B2 or R&S UPL-B29 in base rate mode 35 kHz to 106 kHz with R&S UPL-B29 in high rate mode synchronous to DAI or DARS
Format	professional and consumer format to AES3 or IEC-958 as well as user-definable formats at all inputs

Measurement functions

All measurements at 24 bit, full scale

RMS value, wideband

Measurement bandwidth	up to 0.5 times the clock rate
Accuracy	
AUTO FAST	±0.1 dB
AUTO	±0.01 dB
FIX	±0.001 dB

Integration time

AUTO FAST/AUTO	4.2 ms/42 ms, at least 1 cycle
VALUE	1 ms to 10 s
GEN TRACK	2.1 ms, at least 1 cycle

Filter

weighting filters and user-definable filters, up to 3 filters can be combined post-FFT of filtered signal

Spectrum

³⁾ No DC offset for signal generation with Low Dist ON. With DC offset the AC voltage swing will be reduced; specified inherent distortion values apply to DC offset = 0.

RMS value, selective

Bandwidth (–0.1 dB)	1%, 3%, 1/12 octave, 1/3 octave and user-selectable fixed bandwidth, min. bandwidth 20 Hz
Selectivity	100 dB, bandpass or bandstop filter, 8th order elliptical filter
Frequency setting	– automatic to input signal – coupled to generator – fixed through entered value – sweep in selectable range
Accuracy	±0.2 dB + ripple of filters

Peak value

Measurement	peak max, peak min, peak-to-peak, peak absolute
Accuracy	±0.2 dB at 1 kHz
Interval	20 ms to 10 s
Filter ¹⁾	weighting filters and user-definable filters, up to 3 filters can be combined

Quasi-peak

Measurement, accuracy	to CCIR 468-4
Filter ¹⁾	weighting filters and user-definable filters, up to 3 filters can be combined

DC voltage

Measurement range	0 to ±FS
Accuracy	±1%

S/N measurement routine

available for measurement functions:
– rms, wideband
– peak, quasi-peak
indication of S/N ratio in dB, no post-FFT see FFT analyzer section

FFT analysis**Total harmonic distortion (THD)**

Fundamental	10 Hz to 21.90 kHz
Frequency tuning	automatic to input or generator signal or fixed through entered value
Weighted harmonics	any combination of d_2 to d_3 up to 21.90 kHz ±0.1 dB
Accuracy	
Inherent distortion ²⁾	
Fundamental	42 Hz to 21.90 kHz <–130 dB
24 Hz to 42 Hz	<–112 dB
12 Hz to 24 Hz	<–88 dB
Spectrum	bar chart showing signal and distortion

THD+N and SINAD

Fundamental	10 Hz to 21.90 kHz
Frequency tuning	automatic to input or generator signal or fixed through entered value
Stopband range	fundamental ±28 Hz, max. up to 2nd harmonic
Bandwidth	upper and lower frequency limit selectable, one weighting filter in addition
Accuracy	±0.3 dB
Inherent distortion ²⁾	
Bandwidth	20 Hz to 21.90 kHz
Fundamental	28 Hz to 21.90 kHz <–126 dB
24 Hz to 28 Hz	<–109 dB
20 Hz to 24 Hz	<–96 dB
Spectrum	post-FFT of filtered signal

Modulation factor (MOD DIST)

Measurement method	selective to DIN IEC 268-3
Frequency range	
Lower frequency	30 Hz to 2700 Hz ³⁾
Upper frequency	$8 \times LF^{(3)}$ to 21.25 kHz
Accuracy	±0.2 dB
Inherent distortion ²⁾	
Level LF:UF	1:1 <–133 dB
4:1	<–123 dB
10:1	<–115 dB
Spectrum	bar chart showing signal and distortion

¹⁾ With R&S UPL-B29 only in base rate mode.

²⁾ Total inherent distortion of analyzer and generator.

³⁾ Fixed frequency, independent of sampling rate.

Difference frequency distortion (DFD)

Measurement method	selective to DIN IEC 268-3 or 118
Frequency range	
Difference frequency	80 Hz to 2 kHz ³⁾
Center frequency	200 Hz to 20.90 kHz
Accuracy	±0.2 dB
Inherent distortion ²⁾	DFD d_2 <–130 dB
	DFD d_3 <–130 dB
Spectrum	bar chart showing signal and distortion

Wow and flutter

Measurement method	DIN/IEC, NAB, JIS, 2-sigma to IEC-386
Weighting filter	OFF highpass 0.5 Hz, bandwidth 200 Hz
	ON bandpass 4 Hz to IEC-386
Accuracy	±3%
Inherent noise	<0.0003% weighted <0.0008% unweighted
Spectrum	post-FFT of demodulated signal

Time domain display (WAVEFORM)

Trigger	rising/falling edge
Trigger level	–1 FS to +1 FS, interpolated between samples
Trace length	max. 7424 points
Standard mode	1- to 32-fold interpolation
Compressed mode	32- to 1024-fold compression (envelope for AGC measurement)

Frequency⁴⁾

Frequency range	20 Hz to 20 kHz
Accuracy	±50 ppm

Phase⁴⁾

Frequency range	20 Hz to 20 kHz
Accuracy	±0.5°

Group delay⁴⁾

Frequency range	20 Hz to 20 kHz
Accuracy in seconds	$\Delta\phi/(\Delta f \times 360)$, where $\Delta\phi$ = phase accuracy in °, Δf = frequency step

Polarity test

Measurement	polarity of unsymmetrical input signal
Display	+POL, –POL

Digital generator (option R&S UPL-B2 or -B29)

Frequency limits specified for the signals apply to a sampling rate of 48 kHz. For other sampling rates limits are calculated according to the formula:
 $f_{\text{new}} = f_{48 \text{ kHz}} \times \text{sampling rate}/48 \text{ kHz}$.

Outputs

Balanced output	XLR connector, transformer coupling
Impedance	110 Ω , short-circuit-proof
Level (V_{pp} into 110 Ω)	0 V to 8 V, in 240 steps
Accuracy	±1 dB (rms)
Unbalanced output	BNC, transformer coupling
Impedance	75 Ω , short-circuit-proof
Level (V_{pp} into 75 Ω)	0 V to 2 V, in 240 steps
Accuracy	±1 dB (rms)
Optical output	TOSLINK
Channels	1, 2 or both
Audio bits	8 to 24
Clock rate	35 kHz to 55 kHz with R&S UPL-B2 or R&S UPL-B29 in base rate mode 35 kHz to 106 kHz with R&S UPL-B29 in high rate mode
Format	internal: generator clock or synchronization to analyzer external: synchronization to word clock input, video sync, DARS, 1024 kHz professional and consumer format to AES3 or IEC-958 as well as user-definable formats at all outputs

⁴⁾ Only for measurement functions RMS, FFT and THD+N, accuracy applies to 8k FFT with zoom factor 2, Rife-Vincent-2 window; S/N ratio >70 dB. Phase and group delay in high rate mode only with RMS without filter.

Signals

All signals with 24 bit, full scale

General characteristics

Level resolution	2 ⁻²⁴
Audio bits	8 to 24 bits, LSB rounded off for sine, stereo sine, DFD and MOD DIST in high rate mode for sine only
Dither	Gaussian, triangular, rectangular
Distribution Level	2 ⁻²⁴ FS to 1 FS
Frequency accuracy	±50 ppm (internal clock), ±1 ppm relative to clock rate for sine, stereo sine, DFD and MOD DIST
Frequency offset	0 or +1000 ppm
DC offset	0 to ±1 FS adjustable

Sine

Frequency range	2 Hz ¹⁾ to 21.90 kHz
Total harmonic distortion (THD)	<−133 dB
Sweep parameters	frequency, level

MOD DIST

Frequency range	for measuring the modulation distortion
Lower frequency	30 ¹⁾ to 2700 Hz ¹⁾
Upper frequency	8 x LF ¹⁾ to 21.90 kHz
Level ratio (LF:UF)	selectable from 10:1 to 1:1
Inherent distortion ²⁾	
Level LF:UF	1:1 <−133 dB
	4:1 <−123 dB
	10:1 <−115 dB
Sweep parameters	upper frequency, level

DFD

Frequency range	for measuring the difference tone
Difference frequency	80 Hz to 2 kHz ¹⁾
Center frequency	200 Hz ¹⁾ to 20.90 kHz
Inherent distortion ²⁾	
DFD d ₂	<−130 dB
DFD d ₃	<−130 dB
Sweep parameters	center frequency, level

Multi-sine

Frequency range	2.93 Hz to 21.90 kHz
Frequency spacing	adjustable from 2.93 Hz
Frequency resolution	<0.01% or matching FFT frequency spacing
Dynamic range	>133 dB
Characteristics	

Mode 1	1 to 17 spectral lines – level and frequency selectable for each line – phase of each component optimized for minimum crest factor – phase of each component or crest factor selectable (with R&S UPL-B6)
Mode 2	1 to 7400 spectral lines (noise in frequency domain), distribution: white, pink, 1/3 octave, defined by file; crest factor selectable (with R&S UPL-B6)

Sine burst, sine² burst

Burst time	1 sample up to 60 s, 1-sample resolution
Interval	burst time up to 60 s, 1-sample res.
Low level	0 to burst level, absolute or referred to burst level (0 for sine ² burst)
Sweep parameters	burst frequency, level time, interval

Noise

Distribution	Gaussian, triangular, rectangular
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Arbitrary waveform

File format	loaded from file
*.TTF (internal)	memory depth max. 16 k
*.WAV ³⁾	reproduction of audio files (mono), duration approx. 10 s per Mbyte RAM
Clock rate	sampling rate of generator

Polarity test signal

Sine ² burst with following characteristics:	
Frequency	1.2 kHz ¹⁾
On-time	1 cycle
Interval	2 cycles

FM signal

Carrier frequency	2 Hz ¹⁾ to 21.9 kHz
Modulation frequency	1 mHz ¹⁾ to 21.9 kHz
Modulation	0% to 100%

AM signal

Carrier frequency	2 Hz ¹⁾ to 21.9 kHz
Modulation frequency	1 mHz ¹⁾ to 21.9 kHz
Modulation	0% to 100%

DC voltage

Level range	0 to ±1 FS, can be swept
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Digital audio protocol (option R&S UPL-B21)

Generator

Validity bit	NONE, L, R, L+R
Channel status data	mnemonic entry with user-definable masks, predefined masks for professional and consumer format to AES3 or IEC-958
User data	loaded from file (max. 384 bits) or set to zero

Analyzer

Display	validity bit L and R
Error indication	block errors, sequence errors, clock rate errors, preamble errors
Clock rate measurement	50 ppm
Channel status display	user-definable mnemonic display of data fields, predefined settings for professional and consumer format to AES3 or IEC-958, binary and hexadecimal format
User bit display	user-definable mnemonic display, block-synchronized

Jitter and interface test (option R&S UPL-B22)

Generator

Jitter injection	
Waveform	sine, noise
Frequency range	10 Hz to 21.75 kHz (sine to 110 kHz with option R&S UPL-B1)
Amplitude (peak-to-peak)	0 to 5 UI (corresp. to 0 to 800 ns at f _A = 48 kHz) for balanced output
Common mode signal	
Waveform	sine
Frequency range	20 Hz to 21.75 kHz (110 kHz with option R&S UPL-B1)
Amplitude (V _{pp})	0 V to 20 V
Phase (output to reference)	adjustable between −64 and +64 UI (corresp. to ±50% of frame)
Cable simulator	100 m typical audio cable

¹⁾ Fixed frequency, independent of sampling rate.

²⁾ Total inherent distortion of analyzer and generator.

³⁾ With R&S UPL-B29 only in base rate mode.

Analyzer

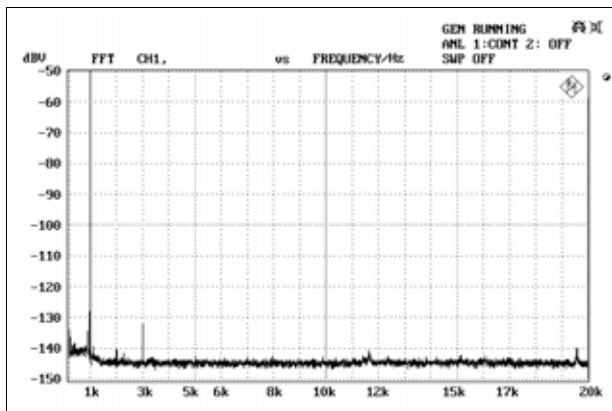
Input signal	
Amplitude (V_{pp})	0 V to 10 V
Clock rate	35 kHz to 55 kHz with R&S UPL-B2 35 kHz to 106 kHz with R&S UPL-B29
Jitter measurement	amplitude, frequency, spectrum 0 to 5 UI typ. for $f < 500$ Hz, decreasing to 0.5 UI for up to 50 kHz 200 ps (noise floor with 8k FFT)
Measurement limit	input signal sampled with low-jitter clock signal and available at reference output (XLR connector on rear)
Reclocking	at balanced input
Common mode test	
Amplitude (V_{pp})	0 V to 30 V
Frequency, spectrum	20 Hz to 110 kHz
Phase (input to reference)	-64 to +64 UI (corresp. to $\pm 50\%$ of frame)
Delay (input to output)	100 μ s to 500 ms

Coded Audio Signal Generation (option R&S UPL-B23)

For specifications, refer to data sheet PD 0757.6985, Multichannel audio measurements on surround sound decoders".

FFT analyzer

Frequency range	
Digital 48/96 kHz	DC to 21.9/43.8 kHz
ANLG 22/110 kHz	DC to 21.9/110 kHz
Dynamic range	
Digital	>135 dB
ANLG 22 kHz	120 dB/105 dB ¹⁾
ANLG 110 kHz	115 dB/85 dB ¹⁾
Noise floor	
Digital	-160 dB
ANLG 22 kHz	-140 dB/110 dB ¹⁾
ANLG 110 kHz	-120 dB/90 dB ¹⁾
FFT size	256, 512, 1k, 2k, 4k, 8k points (16k with zoom factor 2)
Window functions	rectangular, Hann, Blackman-Harris, Rife-Vincent 1-3, Hamming, flat top, Kaiser ($\beta = 1$ to 20)
Resolution	from 0.05 Hz with zoom, from 5.86 Hz without zoom
Zoom	2 to 128 (2 to 16 with ANLG 110)
Averaging	1 to 256, exponential or normal



Typical noise floor of FFT analysis at analog inputs

Filter

For all analog and digital analyzers. Up to 3 filters can be combined as required. All filters are digital filters with a coefficient accuracy of 32 bit floating point (exception: analog notch filter).

¹⁾ With/without analog notch filter.

Weighting filters

- A weighting
- C message
- CCITT
- CCIR weighted, unweighted
- CCIR ARM
- deemphasis 50/15, 50, 75, J.17
- rumble weighted, unweighted
- DC noise highpass
- IEC tuner
- jitter weighted

User-definable filters

8th order elliptical, type C (for highpass and lowpass filters also 4th order), pass-band ripple $+0/-0.1$ dB, stopband attenuation approx. 20 dB to 120 dB selectable in steps of approx. 10 dB (highpass and lowpass filters: stopband attenuation 40 to 120 dB).

Highpass, lowpass filters	limit frequencies (-0.1 dB) selectable, stopband indicated
Bandpass, bandstop filters	passband (-0.1 dB) selectable, stopband indicated
Notch filter	center frequency and width (-0.1 dB) selectable, stopband indicated
Third octave and octave filters	center frequency selectable, bandwidth (-0.1 dB) indicated
File-defined filters	any 8th order filter cascaded from 4 biquads, defined in the z plane by poles/zeros or coefficients

Analog notch filter

For measurements on signals with high S/N ratio, this filter improves the dynamic range of the analyzer by up to 30 dB to 140 dB for analyzer 22 kHz, or 120 dB for analyzer 110 kHz (typical noise floor of FFT). The filter is also used for measuring THD, THD+N and MOD DIST with dynamic mode precision.

Characteristics	available in analog analyzers with measurement functions: <ul style="list-style-type: none"> - rms, wideband - rms, selective - quasi-peak - FFT analysis
Frequency range	10 Hz to 22.5 kHz center frequency (f_c)
Frequency tuning	- automatic to input signal - coupled to generator - fixed through entered value typ. >30 dB, $f_c \pm 0.5\%$ typ. -3 dB at $0.77 \times f_c$ and $1.3 \times f_c$, typ. $+0/-1$ dB outside $0.5 \times f_c$ to $2 \times f_c$
Stopband	
Passband	

Sweep

Generator sweep

Parameters	frequency, level, with bursts also interval and duration, one- or two-dimensional
Sweep	linear, logarithmic, tabular, single, continuous, manual
Stepping	- automatic after end of measurement - time delay (fixed or loaded table)

Analyzer sweep

Parameters	frequency or level of input signal
Sweep	single, continuous
Trigger	- delayed (0 to 10 s) after input level or input frequency variation, settling function selectable - time-controlled
Settling	for level, frequency, phase, distortion measurements, settling function: exponential, flat or averaging

Sweep speed

Two-channel rms measurement 20 Hz to 20 kHz, 30-point generator sweep logarithmic (frequency measurement switched off, Low Dist off).

with	GEN TRACK	0.5 s
	AUTO FAST	1 s
	AUTO	2.5 s

Display of results

Units	
Level (analog)	V, dBu, dBV, W, dBm, difference (Δ), deviation ($\Delta\%$) and ratio (without dimension, %, dBr) to reference value
Level (digital)	FS, %FS, dBFS, LSBs deviation ($\Delta\%$) or ratio (dBr) to reference value
Distortion	% or dB, referenced to signal amplitude, THD and THD+N in all available level units (absolute or relative to selectable reference value)
Frequency	Hz, difference (Δ), deviation ($\Delta\%$) and ratio (as quotient f/f_{ref} , 1/3 octave, octave or decade) to reference value (entered or stored, current generator frequency)
Phase	$^\circ$, rad, difference (Δ) to reference value (entered or stored)
Reference value (level): Fixed value (entered or stored). Current value of a channel or generator signal: permits direct measurement of gain, linearity, channel difference, crosstalk. In sweep mode, traces (other trace or loaded from file) can be used as a reference too.	
Graphical display of results	
Monitor (not R&S UPL66)	8.4" LCD, colour
Display modes	– display of any sweep trace – display of trace groups – bargraph display with min./max. values – spectrum, also as waterfall display – list of results – bar charts for THD and intermodulation measurements
Display functions	– autoscale – X-axis zoom – full-screen and part-screen mode – 2 vertical, 1 horizontal cursor line – search function for max. values – marker for harmonics (spectrum) – user-labelling for graphs – change of unit and scale also possible for loaded traces
Test reports	
Functions	– screen copy to printer, plotter or file (PCX, HPGL, Postscript) – lists of results – sweep lists – tolerance curves – list of out-of-tolerance values – equalizer traces
Printer driver	supplied for approx. 130 printers
Plotter language	HP-GL
Interfaces	2 x RS-232-C, Centronics, IEC 625 (option R&S UPL-B4)
Storage functions	– instrument settings, optionally with measured values and curves – spectra – sweep results – sweep lists – tolerance curves – equalizer traces
Remote control	via IEC 625-2 (IEEE 488) and RS-232; commands largely to SCPI (option R&S UPL-B4)

Audio monitor (option R&S UPL-B5)

Headphone connector	6.3 mm jack
Output voltage (U_p)	max. 8 V
Output current (I_p)	max. 50 mA
Source impedance	10 Ω , short-circuit-proof
Recommended headphone impedance	600 Ω

Extended analysis functions (option R&S UPL-B6)

Coherence and transfer functions	can be displayed simultaneously
Frequency range	DC to 21.9 kHz
Frequency resolution	from 5.86 Hz
Averaging	2 to 2048
FFT length	256, 512, 1k, 2k, 4k, 8k points
Rub & buzz measurement	simultaneous measurement of frequency response, rub & buzz and polarity ¹⁾
Frequency range	10 Hz to 110 kHz
Tracking highpass filter	2 to 20 times fundamental
Lower/upper frequency limit	selectable
Measurement time (200 Hz to 20 kHz, 200 points log.)	2 s
Multi-sine generator function	extended functions
Mode 1	crest factor or phase of each component selectable
Mode 2	crest factor selectable
Third octave analysis	for analyzer ANLG 22 kHz and digital 48 kHz
Number of third octaves	32
Frequency range	22 Hz to 22 kHz
Level accuracy	± 0.2 dB
Center frequency	± 1.0 dB (IEC 1260, class 0)
22 Hz to 22 kHz	
Stereo sine	in digital generator only
Frequency range	2 Hz ²⁾ to 21.9 kHz
Frequency	adjustable for each channel
Phase	0 to 360 $^\circ$ (same frequency in both channels)
Level	adjustable for each channel or channel ratio 2/1
Sweep parameters	frequency and level of channel 1
Other functions	under development

Hearing aids test accessories (option R&S UPL-B7)

Consisting of acoustic test chamber, acoustic 2 cm³ coupler, various battery adapters, connecting cables, software for measurements to IEC60118 and ANSI S3.22.

Additionally required options R&S UPL-B5 and R&S UPL-B10

¹⁾ With R&S UPL-B29 only in base rate mode.

²⁾ Fixed frequency independent of clock rate.

LAN Interface for R&S UPL06/66 (option R&S UPL-B11)

Connector (rear panel)	RJ45
Supported standards	10Base-T (IEEE standard 10 Mbit/s 802.3) 100Base-Tx (IEEE standard 100 Mbit/s 802.3u) Novell Netware IPX, TCP/IP
LAN client	
Supported protocols	

Modification R&S UPL-U3

Change of source impedance of analog generator to 150 Ω
(instead of 200 Ω set as standard) at the factory

General data

Operating temperature range	0 °C to +45 °C
Storage temperature range	-20 °C to +60 °C
Humidity	max. 85% for max. 60 days, below 65% on average/year, no condensation
EMI	EN 50081-1
EMS	EN 50082-1
Safety standards	DIN EN 61010-1, IEC 1010-1, UL 3111-1, CAN/CSA C 22.2 No. 1010-1
Conformity marks	VDE-GS, UL, cUL
Power supply	100/120/220/230 V \pm 10%, 50 Hz to 60 Hz, 160 VA
Dimensions (W x H x D)	435 mm x 192 mm x 475 mm
Weight	12.6 kg

Ordering information

Order designation

Audio Analyzer	R&S UPL	1078.2008.06
Audio Analyzer (for conformance tests on GSM mobile phones)	R&S UPL16	1078.2008.16
Audio Analyzer (without display and keypad)	R&S UPL66	1078.2008.66

Accessories supplied

power cable, operating manual, backup system disks with MS-DOS operating system, backup program disk with operating and measurement software

Options

Low Distortion Generator	R&S UPL-B1	1078.4400.02
Digital Audio I/O 48 kHz	R&S UPL-B2	1078.4000.02
Digital Audio I/O 96 kHz	R&S UPL-B29	1078.5107.02
Digital Audio Protocol	R&S UPL-B21	1078.3856.02
Jitter and Interface Test	R&S UPL-B22	1078.3956.02
Coded Audio Signal Generation	R&S UPL-B23	1078.5188.02
Remote Control	R&S UPL-B4	1078.3804.02
Audio Monitor	R&S UPL-B5	1078.4600.03
Extended Analysis Functions	R&S UPL-B6	1078.4500.02
Hearing Aids Test Accessories	R&S UPL-B7	1090.2704.02
Mobile Phone Test Set	R&S UPL-B8	1117.3505.02
3G Mobile Phone Tests	R&S UPL-B9	1154.7500.02
Universal Sequence Controller	R&S UPL-B10	1078.3904.02
LAN Interface for R&S UPL06/66	R&S UPL-B11	1154.7600.02
Line Measurement to ITU-T O.33	R&S UPL-B33	1078.4852.02
XLR/BNC Adapter Set	R&S UPL-Z1	1078.3704.02
150 Ω Modification	R&S UPL-U3	1078.4900.02

Recommended extras

19" Rack Adapter	R&S ZZA-94	0396.4905.00
Service manual		1078.2089.24
Audio Switcher (Input, female)	R&S UPZ	1120.8004.02
Audio Switcher (Output, male)	R&S UPZ	1120.8004.03



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